

**Notice of References Cited**

Application/Control No.

09/972,964

Applicant(s)/Patent Under

Reexamination  
CHINO ET AL.

Examiner

Christopher W Lattin

Art Unit

2812

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-US004486760	12-1984	Funada et al.	347/256
	B	US-US004790632	12-1988	Miyakawa et al.	349/95
	C	US-US004842379	06-1989	Oishi et al.	349/2
	D	US-US005321789A	06-1994	Kida et al.	385/133
	E	US-US006421103B2	07-2002	Yamaguchi	349/61
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP02001188230A	07-2001	Japan	Yamaguchi	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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